DS - 03/26/2 EVECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

Title of Invention

IC DESIGN DENSITY CHECKING METHOD, SYSTEM AND PROGRAM PRODUCT

Application Number:

10/708,820

Confirmation Number:

First Named Applicant:

William DeCamp

Attorney Docket Number:

BUR920030164US1

Art Unit:

2825

face Dinh

Examiner:

Paul Dinh

Search string:

(6493658 or 6189130 or 6134702 or 20020066064).pn

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
PD	1	6493658	2002-12-10	Koford et al.			
PD	2	6189130	2002-05-30	Gofman et al.	2001-2-13		
PD	3	6134702	2000-10-17	Scepanovic et al.			

US Published Applications

Note: Applicant is not required to submit a paper copy of cited US Published Applications

init	Cite.No.	Pub. No.	Date	Applicant	Kind	Class	Subclass
PD	1	20020066064	2002-05-03	Kamath et al.			

Signature

Examiner Name	Date
/Paul Dinh/	05/09/2006

KEH 6-28-06